

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Robert W. Sharps

Examiner: TBA

Serial No:

Group Art Unit: TBA

Filed:

For: SYSTEM AND METHOD FOR  
MEASURING BIREFRINGENCE IN AN  
OPTICAL MATERIALINFORMATION DISCLOSURE STATEMENT  
UNDER 37 C.F.R. §§ 1.56, 1.97 – 1.98Commissioner of Patents  
Alexandria, VA 22313-1450

Dear Sir:

The Examiner's attention is hereby directed to the following reference(s) listed on the attached Form PTO-1449 for consideration in connection with the examination of the above-identified patent application. One copy of the reference(s) is enclosed.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the enclosed documents constitute "prior art." If it should be determined that any of the submitted documents do not constitute "prior art" under United States law, applicant(s) reserve the right to present to the office the relevant facts and law regarding the appropriate status of such documents.

Applicant(s) further reserve the right to take appropriate action to establish the patentability of the disclosed invention over the enclosed references, should one or more of the references be applied against the claims of the present application.

Respectfully submitted,



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Date: December 11, 2003

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to Commissioner of Patents, Alexandria, Va 22313-1450 on December 11, 2003

Date of Deposit

Thomas R. Beall  
Name of applicant, assignee, or  
Registered Representative

  
Signature

December 11, 2003  
Date of Signature

FORM PTO-1449 (MODIFIED)		ATTORNEY DOCKET NO.	SERIAL NO.
<p style="text-align: center;"><b>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT</b></p>		WJT003-0043 (SP03-172)	
		APPLICANT Robert W. Sharps	
		FILING DATE	GROUP: TBA

**REFERENCE DESIGNATION**      **U.S. PATENT DOCUMENTS**

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
	AA	5,521,705	05-28-96	Rudolf Oldenbourg et al.	356	368	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
	AL						
	AM						
	AN						
	AO						
	AP						
	AQ						

**OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)**

AR	R. Oldenbourg et al., "New polarized light microscope with precision universal compensator", Journal of Microscopy, Vol. 180, Pt. 2, November 1995, pg. 140-147
AS	B. Wang et al., "A new instrument for measuring both the magnitude and angle of low level linear birefringence", Review of Scientific Instruments, Vol. 70, No. 10, October 1999, pgs. 3847-3854
AT	R. Oldenbourg, "A new view on polarization microscopy", Nature, Vol. 381, June 27, 1996, pgs. 811-812
AU	
AV	
AW	

EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.